Docket No. 244521US-2 DIV

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Takashi KUROI ET AL.

SERIAL NO: NEW APPLICATION

GAU:

FILED:

HEREWITH

**EXAMINER:** 

FOR:

SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

# INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

Applicant(s) wish to disclose the following information.

#### REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references were submitted in prior application Serial No. 09/401,849 filed September 22, 1999, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

#### RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

### CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

### **DEPOSIT ACCOUNT**

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Gregory J. Maier

Registration No. 25,599

David A. Bilodeau

Registration No. 42,325

Customer Number

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03) Docket No. 244521US-2 DIV

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				APPLICANT					
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				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
	AA	6,515,338	02/04/03	INUMIYA ET AL.					
	AB	6,104,077	08/15/00	GARDNER ET AL.					
	AC	6,242,776	06/05/01	HAUSE ET AL.					
	AD	6,064,107	05/16/00	YEH					
	AE	5,834,816	11/10/98	JANG					
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	AG	5,880,508	03/09/99	WU					
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